Silicon P Channel Power MOS FET High Speed Power Switching

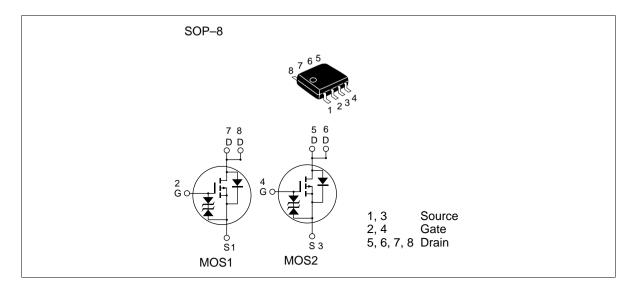
HITACHI

ADE-208-522 (Z) 1st. Edition May 1997

Features

- Low on-resistance
- Capable of 2.5 V gate drive
- Low drive current
- High density mounting

Outline





Absolute Maximum Ratings ($Ta = 25^{\circ}C$)

ltem	Symbol	Ratings	Unit
Drain to source voltage	V _{DSS}	-20	V
Gate to source voltage	V _{GSS}	±10	V
Drain current	I _D	-3.5	A
Drain peak current	Note1 D(pulse)	-28	A
Body-drain diode reverse drain current	I _{DR}	-3.5	A
Channel dissipation	Pch Note2	2	W
Channel dissipation	Pch Note3	3	W
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Note: 1. $PW \le 10\mu s$, duty cycle $\le 1 \%$

2. 1 Drive operation : When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW≤ 10s

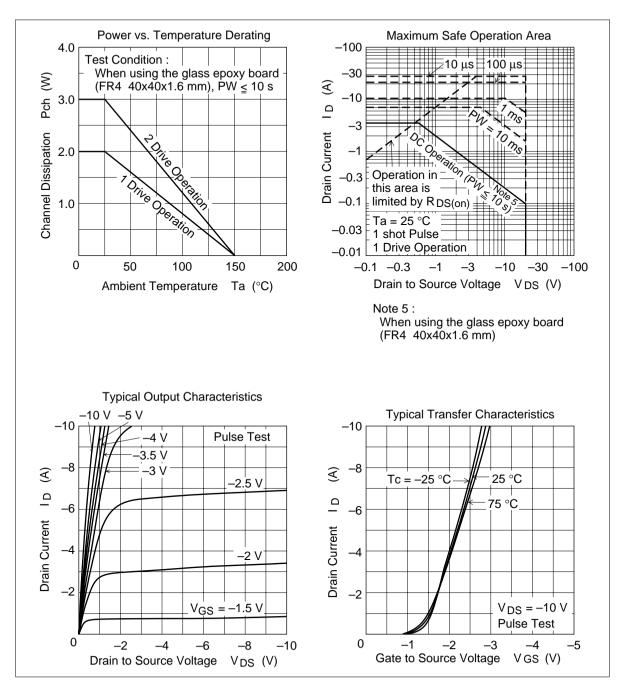
3. 2 Drive operation : When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW≤ 10s

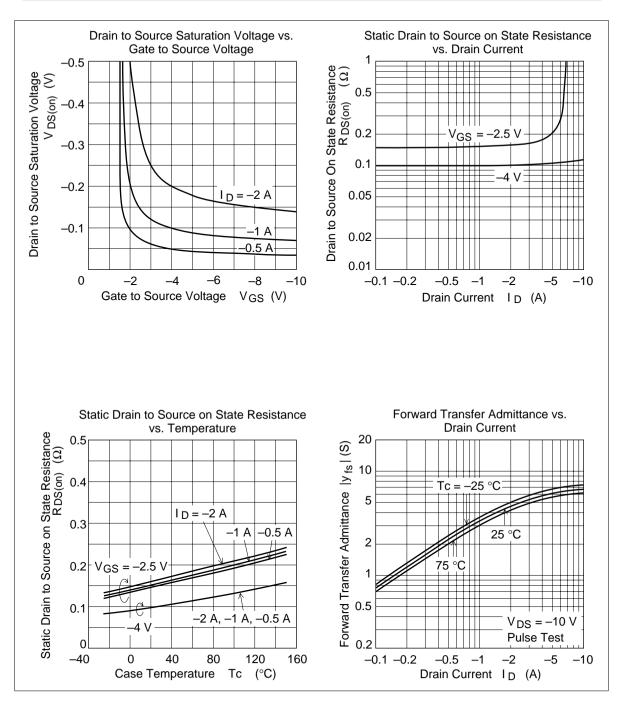
Electrical Characteristics (Ta = 25°C)

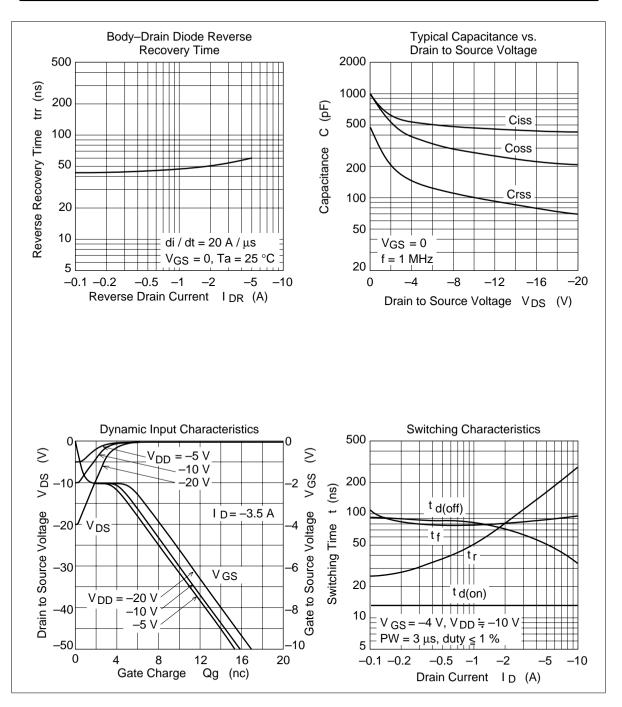
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	-20	—	—	V	$I_{\rm D} = -10$ mA, $V_{\rm GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	±10	—	—	V	$I_{\rm G}=\pm 100 \mu A, \ V_{\rm DS}=0$
Gate to source leak current	I _{GSS}	—		±10	μΑ	$V_{GS} = \pm 8V$, $V_{DS} = 0$
Zero gate voltege drain current	I _{DSS}			-1	μΑ	$V_{\rm DS} = -20$ V, $V_{\rm GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	-0.5		-1.5	V	$V_{DS} = -10V, I_{D} = -1mA$
Static drain to source on state	R _{DS(on)}	_	0.10	0.14	Ω	$I_{\rm D} = -2A, V_{\rm GS} = -4V^{\rm Note4}$
resistance	R _{DS(on)}	_	0.16	0.23	Ω	$I_{\rm D} = -2A, V_{\rm GS} = -2.5V^{\rm Note4}$
Forward transfer admittance	y _{fs}	3	4.5	_	S	$I_{\rm D} = -2A, V_{\rm DS} = -10V^{\rm Note4}$
Input capacitance	Ciss	_	465		pF	$V_{DS} = -10V$
Output capacitance	Coss	_	270	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	100	_	pF	f = 1MHz
Turn-on delay time	t _{d(on)}	_	14	_	ns	$V_{GS} = -4V, I_D = -2A$
Rise time	t,	_	80	_	ns	$V_{DD} \simeq -10V$
Turn-off delay time	t _{d(off)}	_	70	_	ns	
Fall time	t _f	_	80	_	ns	
Body–drain diode forward voltage	V_{DF}	—	-0.95	-1.24	V	$IF=-3.5A,V_{GS}=0^{Note4}$
Body–drain diode reverse recovery time	t _{rr}	—	55	_	ns	$IF = -3.5A, V_{GS} = 0$ diF/ dt =20A/ μ s
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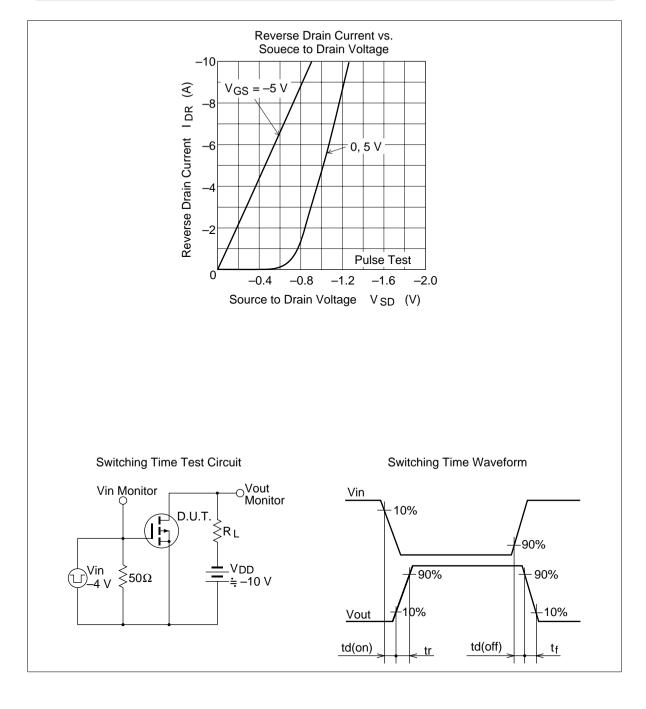
Note: 4. Pulse test

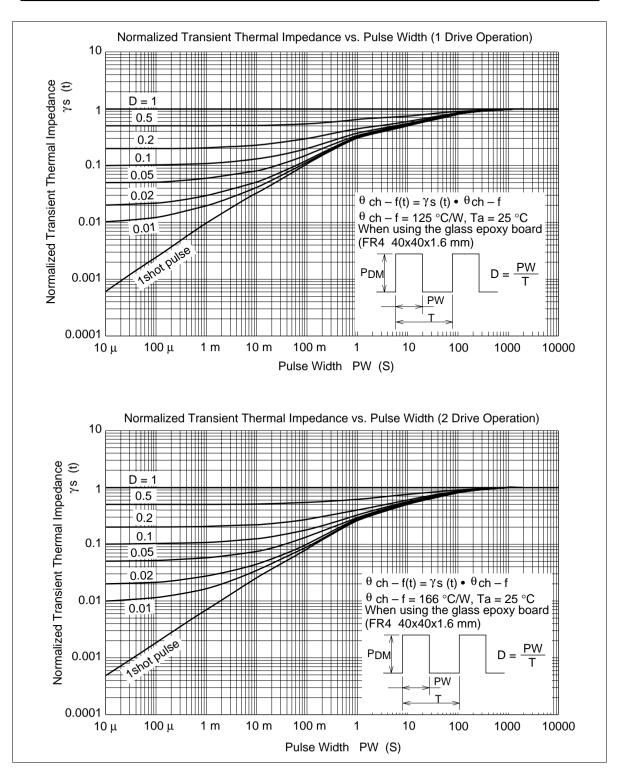
Main Characteristics



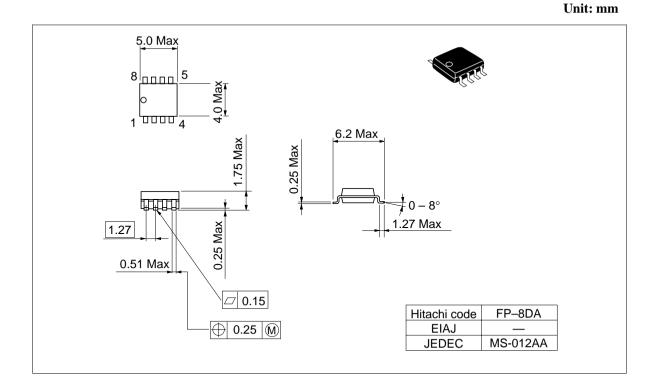








Package Dimensions



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